## **Condensed Matter Physics**

## X-RAY DIFFRACTION AND RAMAN SCATTERING STUDIES OF Pb<sub>1-x</sub> Sr<sub>x</sub>TiO<sub>3</sub> FILMS GROWN BY METALORGANIC DECOMPOSITION

Mackenzie J. Smith and Vaman M. Naik,
Department of Natural Sciences
University of Michigan - Dearborn, Dearborn, MI 48128

Sarah LaPointe, Daad B. Haddad, Punya Talagala, Ratna Naik,\* and Lowell E. Wenger
Department of Physics & Astronomy
Wayne State University, Detroit, MI 48201

\*E-mail: naik@physics.wayne.edu

Gregory W. Auner
Department of Electrical & Computer Engineering
Wayne State University, Detroit, MI 48202

Ferroelectric thin films are of current interest because of their potential in microelectronics applications, including memory devices, sensor technologies, and optoelectronic devices. Thin films of lead titanate PbTiO<sub>3</sub> (PT) and its related solid solutions offer key advantages for a wide variety of applications. For example, the ferroelectric to paraelectric phase transition temperature (Curie temperature) in lead strontium titanate Pb<sub>1-x</sub>Sr<sub>x</sub>TiO<sub>3</sub> (PST) can be adjusted over an exceedingly large temperature range by adjusting the Pb to Sr ratio. Earlier studies on bulk PST for  $0 \le x \le 1$  have shown that the Curie temperature decreases linearly with increasing Sr concentration.

In the present work we have studied  $Pb_{1-x}Sr_xTiO_3$  (x = 0 to 1) films of thickness ~ 4 µm prepared on sapphire and platinum substrates by the metalorganic decomposition (MOD) technique. Separate solutions of  $PbTiO_3$  and  $SrTiO_3$  were mixed to obtain the desired stoichiometric  $Pb_{1-x}Sr_xTiO_3$  metalorganic solution. Films were prepared by dispensing the metalorganic solution onto substrates (2 cm×2 cm×0.25 mm) and spinning them at 4000 rpm for 15 seconds. Multiple coats (30) were made in order to obtain the desired film thickness. Finally the films were annealed at 950°C for 1 hour. X-ray diffraction results show that the films are polycrystalline with a perovskite tetragonal phase for x < 0.6 as seen by the splitting in the (h00) and (001) peaks at room temperature and a cubic phase for x > 0.6. The Raman spectra of the samples were recorded using a single grating spectrometer equipped with a charge coupled detector device and holographic notch filters and the 514.5 nm wavelength light from an argon laser as the excitation source. Room-temperature Raman spectra show a systematic variation of lattice vibrational modes with composition. The most notable changes in the Raman spectra are the coalescence of  $A_1(3TO)$  and E(3TO) modes into one for  $x \ge 0.6$ , and a considerable softening of  $A_1$  (2TO) mode.

<sup>&</sup>lt;sup>1</sup> S. Subrahmanyam and E. Goo, Acta Mater. 46, 817, 1998.

M. J. Smith and S. LaPointe were supported by NSF-REU grant No. EEC-0097736.